Evaluation Board for G = 1, 2, 4, 8, **10 MHz**, 20 V/ μ s Programmable Gain In-Amp

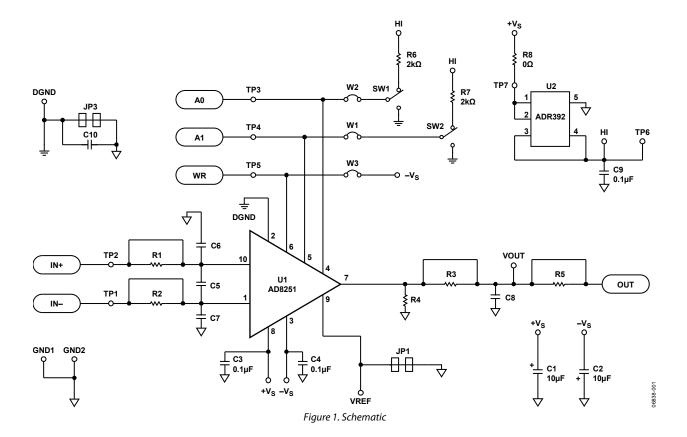
AD8251-EVALZ

FEATURES

Quick evaluation On-board gain control switches SMA connectors for high speed gain testing

GENERAL DESCRIPTION

The AD8251-EVALZ is designed to enable quick evaluation of the AD8251 programmable gain instrumentation amplifier (PGIA). The evaluation board includes on-board gain setting switches to quickly demonstrate the software gain programmability of the AD8251. In addition, an external logic generator can be connected to the AD8251-EVALZ SMA ports to test the gain control of the PGIA.



Rev. 0

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EVALUATION BOARD HARDWARE QUICK START GUIDE

By default, the AD8251-EVALZ is configured for gain change using the on-board switches, SW1 and SW2, as shown in Table 1.

8 8					
W3 (Jumper)	SW2	SW1	Gain		
In place	Low	Low	1		
In place	Low	High	2		
In place	High	Low	4		
In place	High	High	8		

Table 2. Default Settings (From the Factory)

Name	Default Status
W1, W2, W3	In place (tied)
JP1, JP3, R1, R2, R3, R5	Shorted by design (on trace)

USING EXTERNAL LOGIC TO CHANGE GAIN

The AD8251-EVALZ accepts external logic signals such as those from logic generators or FPGAs. To change gains using external logic signals, Jumper W1, Jumper W2, and Jumper W3 must be removed. Only then are the A0, A1, and $\overline{\rm WR}$ pins on the AD8251 directly tied to TP3, TP4, and TP5 (and to the respective SMA connectors). External logic can be tied via the test points TP3, TP4, and TP5, or via the respective SMA connector.

TERMINATION

The AD8251-EVALZ has 50 Ω traces leading to the A0, A1, and $\overline{\rm WR}$ pins. However, it does not have terminations to those pins. If terminations are added, remove Jumper W1, Jumper W2, and Jumper W3.

RFI FILTER

An RFI filter pattern is included at the input traces of the AD8251-EVALZ. R1 and R2 are shorted. The shorted traces must be cut before R1 and R2 are placed on the board.

OUTPUT FILTER

An output filter pattern is included at the output trace of the AD8251-EVALZ. To use R3 or R5 in a filter, cut the shorted traces prior to placing resistors in those locations.

REFERENCE

To level shift the output, a nonzero reference voltage can be applied to REF. By default, REF is tied to analog GND. Cutting the trace at JP1 opens the connection between REF and analog GND.

ANALOG AND DIGITAL GROUND

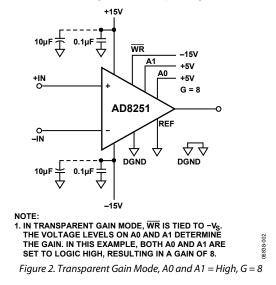
Analog and digital grounds are tied at JP3. To sever the connection between them, JP3 can be cut with a knife to open the connection between the two grounds.

GAIN SELECTION (FROM AD8251 DATA SHEET)

This section shows users how to configure the AD8251 for basic operation. Logic low and logic high voltage limits are listed in the Specifications section of the AD8251 data sheet. Typically, logic low is 0 V and logic high is 5 V; both voltages are measured with respect to DGND. Refer to the specifications table of the AD8251 for the permissible voltage range of DGND. The gain of the AD8251 can be set using two methods.

Transparent Gain Mode

The easiest way to set the gain is to program it directly via a logic high or logic low voltage applied to A0 and A1. Figure 2 shows an example of this gain setting method, referred to throughout the data sheet as transparent gain mode. Tie WR to the negative supply to engage transparent gain mode. (On the AD8251-EVALZ board, put Jumper W3 in place.) In this mode, any change in voltage applied to A0 and A1 from logic low to logic high, or vice versa, immediately results in a gain change. Table 3 is the truth table for transparent gain mode and Figure 2 shows the AD8251 configured in transparent gain mode.



WR (W3)	A1 (SW2)	A0 (SW1)	Gain
–Vs (in place)	Low	Low	1
–Vs (in place)	Low	High	2
–Vs (in place)	High	Low	4
–Vs (in place)	High	High	8

Latched Gain Mode

Some applications have multiple programmable devices such as multiplexers or other programmable gain instrumentation amplifiers on the same PCB. In such cases, devices can share a data bus. The gain of the AD8251 can be set using \overline{WR} as a latch, allowing other devices to share A0 and A1. Figure 3 shows a schematic using this method, known as latched gain mode. (On the AD8251-EVALZ, remove the W1, W2, and W3 jumpers, and drive A0, A1, and \overline{WR} with external logic to test this gain setting mode.) The AD8251 is in this mode when \overline{WR} is held at logic high or logic low, typically 5 V and 0 V, respectively. The voltages on A0 and A1 are read on the downward edge of the \overline{WR} signal as it transitions from logic high to logic low. This latches in the logic levels on A0 and A1, resulting in a gain change. See the truth table listing in Table 4 for more information on these gain changes.

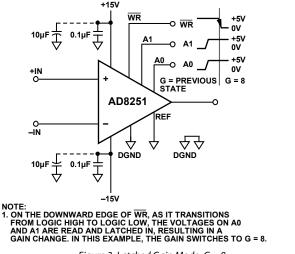


Figure 3. Latched Gain Mode, G = 8

Table 4. Truth Table Logic Levels for Latched Gain Mode

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WR ¹	A1 ¹	A0 ¹	Gain			
High to low	Low	Low	Change to 1			
High to low	Low	High	Change to 2			
High to low	High	Low	Change to 4			
High to low	High	High	Change to 8			
Low to low	X ²	X ²	No change			
Low to high	X ²	X ²	No change			
High to high	X ²	X ²	No change			

¹ Jumper W1, Jumper W2, and Jumper W3 must be removed and external logic must be used to test latched gain mode.

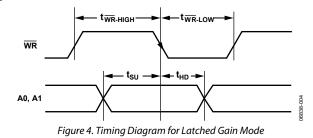
 2 X = don't care.

On power-up, the AD8251 defaults to a gain of 1 when in latched gain mode. In contrast, if the AD8251 is configured in transparent gain mode, it starts at the gain indicated by the voltage levels on A0 and A1 upon power-up.

Timing for Latched Gain Mode

In latched gain mode, logic levels at A0 and A1 have to be held for a minimum setup time, t_{SU} , before the downward edge of WR latches in the gain. Similarly, they must be held for a minimum hold time of t_{HD} after the downward edge of WR to ensure that the gain is latched in correctly. After t_{HD} , A0 and A1 may change logic levels but the gain does not change (until the next downward edge of WR). The minimum duration that WR can be held high is t \overline{WR} -HIGH, and t \overline{WR} -LOW is the minimum duration that \overline{WR} can be held low. Digital timing specifications are listed in the Specification section of the AD8251 data sheet. The time required for a gain change is dominated by the settling time of the amplifier. A timing diagram is shown in Figure 4.

When sharing a data bus with other devices, logic levels applied to those devices can potentially feed through to the output of the AD8251. Feedthrough can be minimized by decreasing the edge rate of the logic signals. Furthermore, careful layout of the PCB also reduces coupling between the digital and analog portions of the board.



AD8251-EVALZ

ORDERING INFORMATION

ORDERING GUIDE

Model AD8251-EVALZ¹

/ALZ¹ Evaluation Board

Package Description

 1 Z = RoHS Compliant Part.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

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